Search Notes



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Ewart, James D

Applicant(s)/Patent Under Reexamination

CHANG ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
455	12.1, 13.1, 427, 429, 456, 458, 562	03-14-2007	JDE
342	357.01, 357.16, 457		
244	158R		<u> </u>

SEARCH NOTES

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Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
same as		3-14-2007	JDE
above			